MOSFET – Power, Dual, N-Channel with Integrated Schottky, SO8FL

30 V, High Side 18 A / Low Side 23 A

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Low Side MOSFET with Integrated Schottky
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

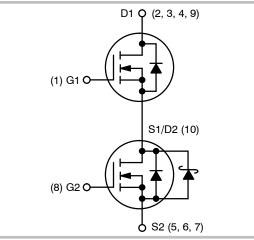
- DC-DC Converters
- System Voltage Rails
- Point of Load



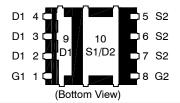
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
Q1 Top FET	6.5 mΩ @ 10 V	10 /
30 V	10 mΩ @ 4.5 V	18 A
Q2 Bottom	4.1 mΩ @ 10 V	23 A
FET 30 V	6.2 mΩ @ 4.5 V	23 A



PIN CONNECTIONS



MARKING DIAGRAM



DFN8 CASE 506BX



4902NF = Specific Device Code A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter				Symbol	Value	Unit
Drain-to-Source Voltage			Q1	V _{DSS}	30	V
Drain-to-Source Voltage			Q2			
Gate-to-Source Voltage			Q1	V _{GS}	±20	V
Gate-to-Source Voltage			Q2			
Continuous Drain Current R _{θJA} (Note 1)		T _A = 25°C	Q1	I _D	13.5	
		T _A = 85°C			9.7	1 .
		T _A = 25°C	Q2		17.5	A
		T _A = 85°C			12.6	
Power Dissipation		T _A = 25°C	Q1	P _D	1.90	W
RθJA (Note 1)			Q2		1.99	
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$		T _A = 25°C	Q1	I _D	18.2	
		T _A = 85°C			13.1	1
	Steady	T _A = 25°C	Q2		23	A
	State	T _A = 85°C	1		16.6	
Power Dissipation		T _A = 25°C	Q1	P _D	3.45	W
$R_{\theta JA} \le 10 \text{ s (Note 1)}$			Q2		3.45	
Continuous Drain Current		T _A = 25°C	Q1	I _D	10.3	
R _{θJA} (Note 2)		T _A = 85°C	1		7.4	1 .
		T _A = 25°C	Q2		13.3	A
		T _A = 85°C	1		9.6	
Power Dissipation		T _A = 25 °C	Q1	P_{D}	1.10	W
R _{θJA} (Note 2)			Q2		1.16	
Pulsed Drain Current		TA = 25°C	Q1	I _{DM}	60	Α
		tp = 10 μs	Q2		80	
Operating Junction and Storage Temperature		•	Q1	T _J , T _{STG}	-55 to +150	°C
			Q2			
Source Current (Body Diode)			Q1	I _S	3.4	А
			Q2		4.9	1
Drain to Source dV/dt				dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T		24 A	Q1	EAS	28.8	mJ
$V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_L = XX A_{pk}, L = 0.1 \text{ mH}, R_0$	$_{\rm G}$ = 25 Ω)	27 A	Q2	EAS	36.5	1
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		•		TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	FET	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	Q1	$R_{\theta JA}$	65.9	
	Q2		62.8	
Junction-to-Ambient - Steady State (Note 4)	Q1	$R_{\theta JA}$	113.2	0000
	Q2		108	°C/W
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	Q1	$R_{\theta JA}$	36.2	
	Q2		36.2]

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

FLECTRICAL CHARACTERISTICS (T. = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Co	ondition	Min	Тур	Max	Unit
OFF CHARACTERISTICS								
Drain-to-Source Break-	Q1	V _{(BR)DSS}	$V_{GS} = 0 V$,	I _D = 250 μA	30			V
down Voltage	Q2		$V_{GS} = 0 V$,	I _D = 1.0 mA	30			
Drain-to-Source Break-	Q1	V _{(BR)DSS}				18		mV /
down Voltage Temperature Coefficient	Q2	T _J				15		°C
Zero Gate Voltage Drain	Q1	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1	μΑ
Current			$V_{DS} = 24 V$	T _J = 125°C			10	1
	Q2		V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			500	
Gate-to-Source Leakage	Q1	I _{GSS}	V _{GS} = 0 V, VDS = ±20 V				±100	nA
Current	Q2						±100	1
ON CHARACTERISTICS (Not	e 5)				•	•		
Gate Threshold Voltage	Q1	V _{GS(TH)}	$V_{GS} = VDS$, $I_D = 250 \mu A$		1.2		2.2	V
	Q2				1.2		2.2	1
Negative Threshold Temper-	Q1	V _{GS(TH)} /				4.5		mV /
ature Coefficient	Q2	TJ				4.0		°C
Drain-to-Source On Resist-	Q1	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		5.2	6.5	
ance			V _{GS} = 4.5 V	I _D = 10 A		8.0	10	0
	Q2		V _{GS} = 10 V	I _D = 15 A		3.3	4.1	mΩ
			V _{GS} = 4.5 V	I _D = 15 A		5.0	6.2	
Forward Transconductance	Q1	9FS	$V_{DS} = 1.5 \text{ V}, I_D = 10 \text{ A}$			28		S
	Q2					35		
CHARGES, CAPACITANCES	& GATE	RESISTANCE	E					
land Canaditana	Q1	0				1150		
Input Capacitance	Q2	C _{ISS}				1590]
O. to . t Connections	Q1		C _{OSS} V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			360		
Output Capacitance	Q2	Coss				813		pF
Deveres Consolitance	Q1					105		1
Reverse Capacitance	Q2	C _{RSS}				83		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

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- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

CHARGES, CAPACITANCES & GATE RESISTANCE Total Gate Charge Ω1 / Ω2	Parameter	FET	Symbol	Test Co	ondition	Min	Тур	Max	Unit
Total Gate Charge Q2	CHARGES, CAPACITANCES	& GATE	RESISTANC	E		-	-	<u>-</u>	-
Threshold Gate Charge Q1 Q2 Q3 Q3 Q4 Q5 Q5 Q5 Q5 Q5 Q5 Q5	T. 10 . 0	Q1					9.7		
Threshold Gate Charge Q2 Q3 Q3 Q4 Q4 Q4 Q5 Q5 Q5 Q5 Q5	Total Gate Charge	Q2	$Q_{G(TOT)}$				11.5		<u> </u>
Cate	TI 1 110 1 01	Q1	0				1.1		
Gate - to - Source Charge Q1 QG QG QG QG 3.3 A 4.2 A.2 A.2 A.2 A.2 A.3.7 A.3.7 A.3.7 A.3.7 A.3.7 A.3.7 A.3.7 A.3.4 A.2 A.3.7 A.3.7 A.3.4 A.2 A.3.7	Threshold Gate Charge	Q2	Q _{G(TH)}				1.4		
Gate-to-Drain Charge Q1 Q2 Q3 Q4	0 0 0 .	Q1	_	$V_{GS} = 4.5 \text{ V}, V_{DS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 10 \text{ A}$		3.3		nC
Gate-to-Drain Charge Q2	Gate-to-Source Charge	Q2	Q_GS				4.2		
Total Gate Charge Q1	0	Q1					3.7		
Total Gate Charge Q2	Gate-to-Drain Charge	Q2	Q_GD		İ		3.4		
SWITCHING CHARACTERISTICS (Note 6) 24.9	Table Oaks Observe	Q1	0				19.1		-0
Turn-On Delay Time Q1	iotal Gate Charge	Q2	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 10 \text{ A}$			24.9		nC
Turn-On Delay Time	SWITCHING CHARACTERIS	STICS (No	te 6)						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Time On Dala Time	Q1					9.0		
Rise Time Q2	Turn-On Delay Time	Q2	^t d(ON)			10.5		1	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	D: T:	Q1					15		1
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	Q2	t _r	Vce = 4.5 V. Vce = 15 V.			15.2		
Fall Time Q2		Q1	$I_D = 10 \text{ A}, R_G = 3.0 \Omega$				14		ns
Fall Time Q2 t _f 4.7 4.7	Turn-Off Delay Time	Q2	^t d(OFF)				17.7		1
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	- u-	Q1					4.0		
	Fall Time	Q2	t _f				4.7		1
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	SWITCHING CHARACTERIS	STICS (No	te 6)						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	T O. D.I. T	Q1					6.0		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	Q2	^t d(ON)				7.0		
	Diag Time	Q1					14		
	rise time	Q2	τ _r	$V_{GS} = 10 \text{ V. } V_{DS} = 15 \text{ V.}$	V _{DS} = 15 V,		14		
	T O" Dala T	Q1		$I_D = 10 \text{ A},$	$R_G = 3.0 \Omega$		17		ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	Q2	^t d(OFF)				22		1
	- u-	Q1					3.0		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	raii Time	Q2	t _f				3.3		
Forward Voltage V_{SD} V_{SD} $V_{GS} = 0 \text{ V},$ $V_{GS} = 0 \text{ V},$ $V_{J} = 125 \text{ °C}$ $V_{J} = 25 \text{ °C}$ $V_{J} = 2$	DRAIN-SOURCE DIODE CH	IARACTE	RISTICS						
Forward Voltage V_{SD} V_{SD} V_{SD} $V_{GS} = 0 \text{ V},$ $V_{J} = 125 ^{\circ}\text{C}$ 0.62 $V_{J} = 25 ^{\circ}\text{C}$ 0.37 0.70		6.		V _{GS} = 0 V.	T _J = 25°C		0.75	1.0	
$V_{GS} = 0 \text{ V}, \qquad I_J = 25 \text{ C} \qquad 0.37 \qquad 0.70$		Q1		I _S = 3 A	T _J = 125°C		0.62		
	Forward Voltage		V_{SD}	V _{GS} = 0 V ₂	T _J = 25°C		0.37	0.70	V
		Q2		I _S = 2 A	T _J = 125°C		0.31		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CH	ARACTE	RISTICS					
D D	Q1				23		
Reverse Recovery Time	Q2	t _{RR}			24.5		1
Charra Time	Q1				12		l
Charge Time	Q2	ta	V 0V d /d 400 A / 5 L 0 A		13		ns ns
Disabassa Tisa	Q1	11-	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 3 \text{ A}$		11		
Discharge Time	Q2	tb			11.5		
Daviera Daviera Charre	Q1	0			12		nC
Reverse Recovery Charge	Q2	Q _{RR}			24		
PACKAGE PARASITIC VALU	IES						
Source Inductance	Q1	1			0.38		الم
Source inductance	Q2	L _S	LS		0.65		nH
Duain Industria	Q1				0.054		11
Drain Inductance	Q2	L _D	T 0700		0.007		nH
Outs to the state of	Q1		$T_A = 25^{\circ}C$		1.5		nH
Gate Inductance	Q2	L _G			1.5		
Cata Basistanas	Q1	Б			0.8		0
Gate Resistance	Q2	- R _G			0.8		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFD4902NFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NTMFD4902NFT3G	DFN8 (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{6.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS - Q1

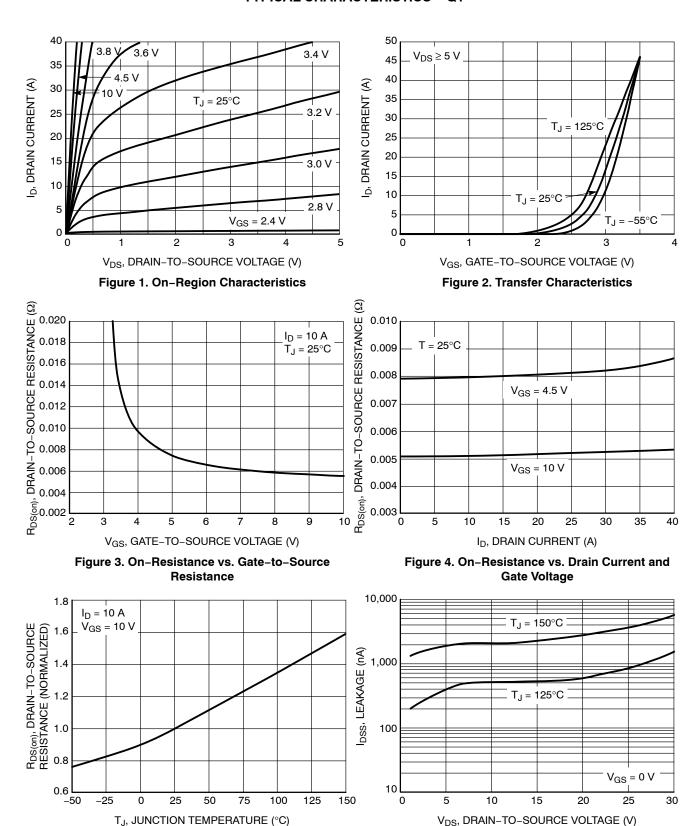


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS - Q1

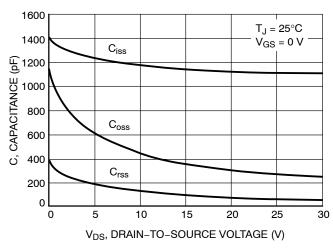


Figure 7. Capacitance Variation

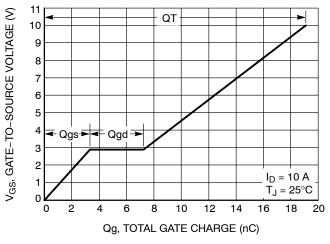


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

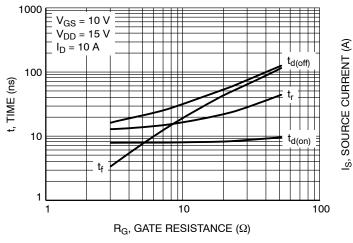


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

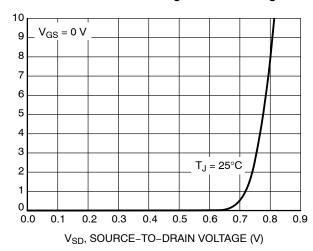
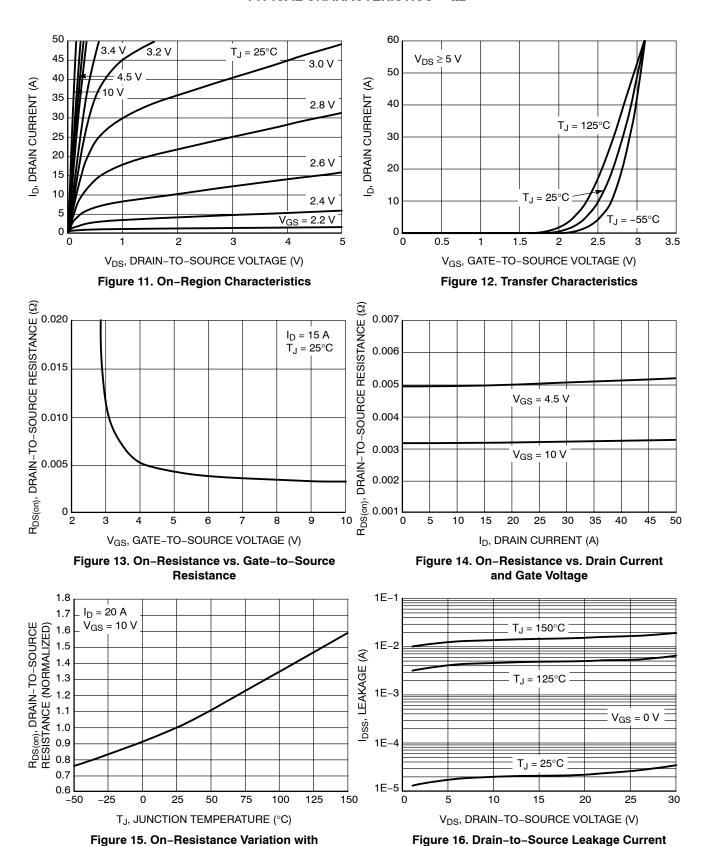


Figure 10. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS - Q2



vs. Voltage

Temperature

TYPICAL CHARACTERISTICS - Q2

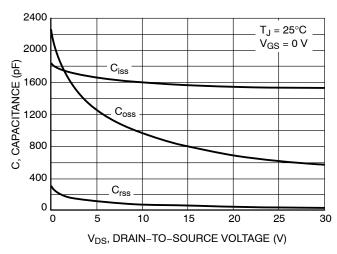


Figure 17. Capacitance Variation

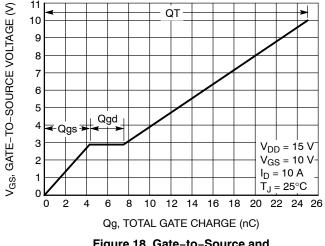


Figure 18. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

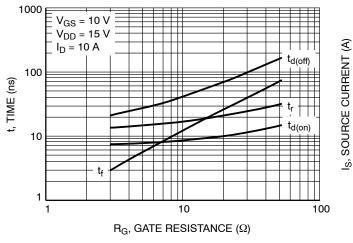


Figure 19. Resistive Switching Time Variation vs. Gate Resistance

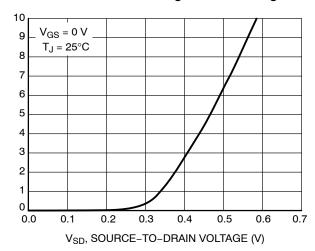
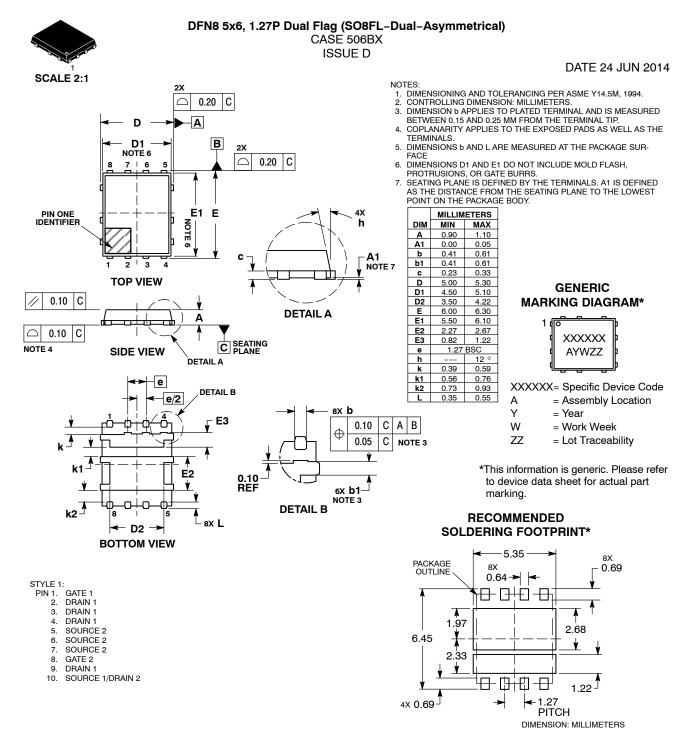


Figure 20. Diode Forward Voltage vs. Current



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

		AG (SO8FL-DUAL-ASYMMETRICAL)	PAGE 1 OF 1	
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